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Application No.	Applicant(s)
09/716,717	HANSEN ET AL.
Examiner	Art Unit

J. Bret Dennison

2143

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	217, 220, 223, 250	3/22/2004	JBD
379		3/22/2004	JBD
395	200.1	3/22/2004	JBD
		_	*

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	EXMR		
East See Search Results	3/20/2004	JBD	
Help from Marc Thompson East See Search Results NPL- ACM, IEEE	1/26/2005	JBD	
Spoke with William Vaughn on 112 issues	2/2/2005	JBD	
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Part of Paper No. 20050106